PATENT COOPERATION TREATY

PCT

INTERNATIONAL-TYPE SEARCH REPORT

(PCT Article 15.5)

National application No. Country or Office of SE		f filing	Applicant's or agent's file reference SEP/3774 SE/C-G FORSBERG
Filing date (day/month/year)		(Earliest) Priority Date (day month year)	
12 March 1999			
Applicant			
CelsiusTech Electronics AB			
Date of request for international-type sea	arch		search request No.
12 March 1999		SE 99/00342	
This international-type search report he to the applicant. This international-type search report contains a like it is also accompanied by a contains a like it is also accompanied.	onsists of a total of _ opy of each prior art	2 sheets. document cited in t	·
1. Certain claims were found uns	searchable (See Box I).	
2. Unity of invention is lacking (See Box II).		
3. The international application international-type search was	contains disclosure o carried out on the ba	f a nucleotide and/o sis of the sequence	r amino acid sequence listing and the listing
file	d with the internation	al application.	
fur	nished by the applica	nt separately from t	he international application,
	but not accordant matter going	npanied by a staten beyond the disclosu	nent to the effect that it did not include are in the international application as filed.
trai	nscribed by this Auth	ority.	

PATENT COOPERATION TREATY

PCT

INTERNATIONAL SEARCH REPORT

Applicant's or agent's file reference 3774 PCT	FOR FURTHER see Notifica ACTION (Form PCI	ation of Transmittal of International Search Report [/ISA/220] as well as, where applicable, item 5 below.
International application No.	International filing date (day/month	(Earliest) Priority Date (day/month/year)
PCT/SE 00/00470	9 March 2000	12 March 1999
Applicant		
CelsiusTech Electronics Al	B et al	
This international search report has applicant according to Article 18. A	been prepared by this International copy is being transmitted to the Inte	Searching Authority and is transmitted to the ernational Bureau.
This international search report cons	sists of a total of3_ sheets.	1
X It is also accompanied by a	a copy of each prior art document ci	ited in this report.
Certain claims were found u Unity of invention is lacking		
7 Vincy w 2.2	; (the box 11).	
3. The international application international search was ca	on contains disclosure of a nucleotid arried out on the basis of the sequen	e and/or amino acid sequence listing and the ce listing
<u> </u>	iled with the international applicatio	1
	urnished by the applicant separately	•
	but not accompanied by matter going beyond the	a statement to the effect that it did not include disclosure in the international application as filed.
, _{[-1}	ranscribed by this Authority.	
	•	
	t and a submitted for	attimene
4. With regard to the title,	the text is approved as submitted by	
[x] '	the text has been established by this	Authorny to read as follows.
Qua	ntum well based two-	dimensional detector for IR
rad	iation and camera sy	stem with such a detector
5. With regard to the abstract,		
	he text is approved as submitted by	
. t · · · · · · · · · · · · · · · · · ·	he text has been established, according Box HI. The applicant may, within national search report, submit comm	ing to Rule 38.2(b), by this Authority as it appears it one month from the date of mailing of this interments to this Authority.
6. The figure of the drawings to be	published with the abstract is:	
	as suggested by the applicant.	None of the figures.
	because the applicant failed to sugge	est a figure.
	because this figure better characteris	zes the invention.

Search request No.

SE 99/00342

A. CLASSIFICATION OF SUBJECT MATTER IPC6: H01L 31/0236, H01L 31/09, G01J 5/20, H04N 5/33 According to International Patent Classification (IPC) or to both national classification and IPC B. FIELDS SEARCHED Minimum documentation searched (classification system followed by classification symbols) IPC6: H01L, G01J, H04N Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched SE,DK,FI,NO classes as above Electronic data base consulted during the international search (name of data base and, where practicable, search terms used) C. DOCUMENTS CONSIDERED TO BE RELEVANT Relevant to claim No. Citation of document, with indication, where appropriate, of the relevant passages Category* 1-10 EP 0617471 A2 (NIPPON TELGRAPH AND TELEPHONE CO.), Α 28 September 1994 (28.09.94), column 9, claim 15 1-10 US 5485015 A (KWONG-KIT CHOI), 16 January 1996 A (16.01.96), figures 7,8 US 5539206 A (THOMAS R.SCHIMERT), 23 July 1996 1-10 Α (23.07.96), abstract Further documents are listed in the continuation of Box C. See patent family annex. later document published after the international filing date or priority date and not in conflict with the application but cited to understand Special categories of cited documents: "A" document defining the general state of the art which is not considered the principle or theory underlying the invention to be of particular relevance "X" document of particular relevance: the claimed invention cannot be erlier document but published on or after the international filing date considered novel or cannot be considered to involve an inventive document which may throw doubts on priority claim(s) or which is step when the document is taken alone cited to establish the publication date of another citation or other "Y" document of particular relevance: the claimed invention cannot be special reason (as specified) considered to involve an inventive step when the document is combined with one or more other such documents, such combination document referring to an oral disclosure, use, exhibition or other means being obvious to a person skilled in the art document published prior to the international filing date but later than the priority date claimed "&" document member of the same patent family Date of mailing of the international-tupe search report Date of the actual completion of the international-type search 1999 -11- 1 9 <u>16 November 1999</u> Name and mailing address of the ISA/ Authorized officer **Swedish Patent Office** Lars Jakobsson

Telephone No. + 46 8 782 25 00

Box 5055, S-102 42 STOCKHOLM

Facsimile No. + 46 8 666 02 86

INTERNATIONAL-TYPE SEARCH REPORT

Information on patent family members

02/11/99

Search request No. SE 99/00342

EP	0617471	A2	28/09/94	JP 7231144 A US 5585957 A US 5689358 A	29/08/95 17/12/96 18/11/97
US	5485015	A	16/01/96	NONE	
US	5539206	A	23/07/96	CA 2220834 A EP 0824762 A JP 11504763 T NO 974814 A WO 9633515 A	24/10/96 25/02/98 27/04/99 17/10/97 24/10/96

International application No.

PCT/SE 00/00470

A. CLASSIFICATION OF SUBJECT MATTER

IPC7: H01L 31/0236, H01L 31/09, G01J 5/20, H04N 5/33 According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC7: H01L, G01J, H04N

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

SE,DK,FI,NO classes as above

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

C. DOCUMENTS CONSIDERED TO BE RELEVANT

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	EP 0617471 A2 (NIPPON TELEGRAPH AND TELEPHONE CO.), 28 Sept 1994 (28.09.94), column 9, claim 15	1-10
A	US 5485015 A (KWONG-KIT CHOI), 16 January 1996 (16.01.96), figures 7,8	1-10
! :		
A	US 5539206 A (THOMAS R. SCHIMERT), 23 July 1996 (23.07.96), abstract	1-10

	X	Further documents are listed in the continuation of Box C.	X See patent family annex.
١	•	Special categories of cited documents:	later document published after the international filing date date and not in conflict with the application but cited to u
ı	"A"	document defining the general state of the art which is not considered	the principle or theory underlying the invention

- to be of particular relevance "E" erlier document but published on or after the international filing date
- document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)
- document referring to an oral disclosure, use, exhibition or other
- document published prior to the international filing date but later than the priority date claimed
- ite or priority understand
- document of particular relevance: the claimed invention cannot be considered novel or cannot be considered to involve an inventive step when the document is taken alone
- document of particular relevance: the claimed invention cannot be considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
- "&" document member of the same patent family

Date of mailing of the international search report Date of the actual completion of the international search

1 4 -07- **2000**

Authorized officer

Name and mailing address of the ISA/

<u>6 July 2000</u>

Swedish Patent Office Box 5055, S-102 42 STOCKHOLM

STURE ELNAS/EE

Facsimile No. + 46 8 666 02 86

+ 46 8 782 25 00 Telephone No.

INTERNATIONAL SEARCH REPORT

International application No.

PCT/SE 00/00470

ategory*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	IEEE ELECTRON DEVICE LETTERS, Volume 16, No 2, February 1995, K. L. Tsai et al, "Two-Dimensional Bi-Periodic Grating Coupled One- and Two-Color Quantum Well Infrared Photodetectors", column 2, line 7, figure 1	1-10

INTERNATIONAL SEARCH REPORT

Information on patent family members

02/12/99

International application No.

PCT/SE 00/00470

	atent document I in search repor	ι	Publication date		Patent family member(s)	Publication date
EP	0617471	A2	28/09/94	JP US US	7231144 A 5585957 A 5689358 A	29/08/95 17/12/96 18/11/97
US	5485015	Α	16/01/96	NON	E	
US	5539206	Α	23/07/96	CA EP JP NO WO	2220834 A 0824762 A 11504763 T 974814 A 9633515 A	24/10/96 25/02/98 27/04/99 17/10/97 24/10/96

PF NT COOPERATION TREAT

	From the INTERNATIONAL BUREAU
PCT	To:
NOTIFICATION OF ELECTION (PCT Rule 61.2) Date of mailing (day/month/year) 01 November 2000 (01.11.00)	Commissioner US Department of Commerce United States Patent and Trademark Office, PCT 2011 South Clark Place Room CP2/5C24 Arlington, VA 22/202 ETATS-UNIS D'AMERIQUE in its capacity as elected Office
	Applicant's or agent's file reference
International application No. PCT/SE00/00470	3774 PCT
International filing date (day/month/year) 09 March 2000 (09.03.00)	Priority date (day/month/year) 12 March 1999 (12.03.99)
Applicant	
LINDAU, Sten	
The designated Office is hereby notified of its election mad X in the demand filed with the International Preliminary 06 October 20 In a notice effecting later election filed with the International Preliminary	y Examining Authority on: 00 (06.10.00)
2. The election X was was not was not made before the expiration of 19 months from the priority Rule 32.2(b).	date or, where Rule 32 applies, within the time limit under

The International Bureau of WIPO 34, chemin des Colombettes 1211 Geneva 20, Switzerland

Facsimile No.: (41-22) 740.14.35

Authorized officer

Manu Berrod

Telephone No.: (41-22) 338.83.38

From the INTERNATIONAL PRELIMINARY EXAMINING AUTHORITY

To:

Bofors Suport AB Patent and Trademarks 691 80 Karlskoga

2001 -03- 2 8

PCT

NOTIFICATION OF TRANSMITTAL OF INTERNATIONAL PRELIMINARY **EXAMINATION REPORT**

(PCT Rule 71.1)

Date of mailing (day/month/year)

25-03-2001

IMPORTANT NOTIFICATION

Applicant's or agent's file reference

3774 PCT

International application No.

International filing date (day/month/year)

Priority date (day/month/year)

PCT/SE00/00470

09-03-2000

12-03-1999

Applicant

CelsiusTech Electronics AB

et al

- The applicant is hereby notified that this International Preliminary Examining Authority transmits herewith the international preliminary examination report and its annexes, if any, established on the international application. 1.
- A copy of the report and its annexes, if any, is being transmitted to the International Bureau for communication 2. to all the elected Offices.
- Where required by any of the elected Offices, the International Bureau will prepare an English translation of the report (but not of any annexes) and will transmit such translation to those Offices. 3.

REMINDER 4.

The applicant must enter the national phase before each elected Office by performing certain acts (filing translations and paying national fees) within 30 months from the priority date (or later in som Offices) (Article 39(1)) (see also the reminder sent by the International Bureau with Form PCT/IB/301).

where a translation of the international application must be furnished to an elected Office, that translation must contain a translation of any annexes to the international preliminary axamination report. It is the applicant's responsibility to prepare and furnish such translation directly to each elected Office concerned.

For further details on the applicable time limits and requirements of the elected Offices, see Volume II of the PCT Applicant's Guide.

Name and mailing address of the \overline{IPEA}

Patent- och registreringsverket

Box 5055

S-102 42 STOCKHOLM

08-667 72 88 Facsimile No.

17978

PATOREG-S

Authorized officer

Telephone Mo.

08-782 25 00

E Rice.

PCT

INTERNATIONAL PRELIMINARY EXAMINATION REPORT

(PCT Article 36 and Rule 70)

Applicant's or agent's file reference 3774 PCT	FOR FURTHER ACTIO	ION See Notification of Transmittal of International Preliminary Examination Report (Form PCT/IPEA/416)			
International application No.	International filing date (day	day/month/year) Priority date (day/month/year)			
	09.03.2000		12.03.1999		
PCT/SE00/00470	<u> </u>				
International Patent Classification (IPC) o	r national classification and it	110 ANT E / 2	2		
H01L 31/0236, H01L 31	/09, G010 5/20,	HU4N 5/5	3		
Applicant					
CelsiusTech Electroni	cs AB et al				
Cersiusiech Licotion					
This international preliminary example Authority and is transmitted to the second control of the second c	e applicant according to Artic	cle 36.	į		
2. This REPORT consists of a total	of 4 sheets, in	cluding this cover	sheet		
been amended and are the	This report is also accompanied by ANNEXES, i.e., sheets of the description, claims and/or drawings which have been amended and are the basis for this report and/or sheets containing rectifications made before this Authority (see Rule 70.16 and Section 607 of the Administrative Instructions under the PCT).				
These annexes consist of a total of	of sheets.				
3. This report contains indications r	elating to the following items:	:			
I Basis of the report	I Basis of the report				
II Priority					
III Non-establishment	of opinion with regard to nove	elty, inventive step	and industrial applicability		
IV Lack of unity of invention					
V Reasoned statement citations and explan	V Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability, citations and explanations supporting such statement				
VI Certain documents	cited				
VII Certain defects in th	e international application	•			
VIII Certain observation	VIII Certain observations on the international application				
Date of submission of the demand		Date of completion	of this report		
06.10.2000	1	15.02.2001			
Name and mailing address of the IPEA/S	SE A	Authorized officer			
Patent- och registreringsverket	Telex 17978				
S-102 42 STOCKHOLM PATOREG-S Sture Elnäs /OGU					
Facsimile No. 08-667 72 88 Telephone No. 08-782 25 00					

Form PCT/IPEA/409 (cover sheet) (January 1998)



INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International	application No.

PCT/SE00/00470

I.	Basi	s of the report	
1.	With	regard to the elements of the international application:*	
	\boxtimes	the international application as originally filed	
		the description:	
		pages	, as originally filed
			, filed with the demand
	_	pages, filed with the letter of	
		the claims:	, as originally filed
		pages, as amended (together with any state pages	filed with the demand
		filed with the letter of	,
		the drawings:	, as originally filed
		pages	, filed with the demand
		pages, filed with the letter of	
		the sequence listing part of the description:	
	ш	pages	, as originally filed
		nages	, filed with the demand
		pages, filed with the letter of	
	These	regard to the language, all the elements marked above were available or furnished to this Authority international application was filed, unless otherwise indicated under this item. elements were available or furnished to this Authority in the following language	which is: (under Rules 55.2 and/ international
*	in to and	The amendments have resulted in the cancellation of: the description, pages the claims, Nos. the drawings, sheet/fig This report has been established as if (some of) the amendments had not been made, since they have been disclosure as filed, as indicated in the Supplemental Box (Rule 70.2 (c)).** clacement sheets which have been furnished to the receiving Office in response to an invitation under his report as "originally filed" and are annexed to this report since they do not contain amendments (70.17). The replacement sheet containing such amendments must be referred to under item I and annexed to this	Article 14 are referred to (Rules 70.16



INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International application No.

PCT/SE00/00470

* 7	Reasoned statement under Article 35(2) with regard to novelty, inventive step or industrial applicability;
	citations and explanations supporting such statement
	Citations and expranations supporting seen sections.

1. Statement

nemeni			
Novelty (N)	Claims Claims	1-10	YES NO
Inventive step (IS)	Claims Claims	1-10	YES NO
Industrial applicability (IA)	Claims Claims	1-10	YES NO

2. Citations and explanations (Rule 70.7)

The claimed invention relates to a quantum well based twodimensional detector for infrared radiation and a camera system with such a detector. The invention is intended to solve the problem of the narrow angle where the detector is sensitive and a poor sensitivity for points at the edge of the detector.

The solution according to the invention is to introduce a grating arrangement with a grating interval that varies or changes from the central part of the detector towards the outer parts.

The documents cited in the International Search Report are:

EP 0617471

US 5485015

US 5539206

IEEE ELECTRON DEVICE LETTERS, Volume 16, No2, February 1995, K.L. Tsai et al, "Two-Dimensional Bi-Periodic Grating Coupled One- and Two-Color Quantum Well Infrared Photodetectors"

Cited documents describe quantum well detectors for infrared detection. Among cited documents, the last is closest to describe the invention. In this document is disclosed a detector having different grating interval in two directions.

However, none of the documents describe a grating system with varying intervals of the grating period.

Accordingly, the claimed invention fulfil the requirements of novelty (N), inventive step (IS) and industrial applicability (IA).



INTERNATIONAL PRELIMINARY EXAMINATION REPORT

International application No.

PCT/SEO0/00470

Y 11.	Certain defects in the international appreciation
	•

The following defects in the form or contents of the international application have been noted:

In the claims and in the abstract, parentheses for the reference signs are missing.

Form PCT/IPEA/409 (Box VII) (January 1998)



For receiving Office use only
International Application No.
International Filing Date
Name of receiving Office and "PCT International Application"

REQUEST The undersigned requests that the present international application be processed according to the Patent Cooperation Treaty. Applicant's or agent's file reference 3774 PCT (if desired) (12 characters maximum) TITLE OF INVENTION Box No. I Meddelas senare APPLICANT Box No. II Name and address: (Family name followed by given name; for a legal entity, full official designation. The address must include postal code and name of country. The country of the address indicated in this Box is the applicant's State (that is, country) of residence if no State of residence is indicated below.) This person is also inventor. Telephone No. CelsiusTech Electronics AB Facsimile No. S-175 88 JÄRFÄLLA Sweden Teleprinter No. State (that is, country) of residence: State (that is, country) of nationality: SE SE the States indicated in the United States all designated States except the United States of America This person is applicant all designated the Supplemental Box of America only for the purposes of: FURTHER APPLICANT(S) AND/OR (FURTHER) INVENTOR(S) Box No. III Name and address: (Family name followed by given name; for a legal entity, full official designation. The address must include postal code and name of country. The country of the address indicated in this Box is the applicant's State (that is, country) of residence if no State of residence is indicated below.) This person is: applicant only applicant and inventor Lindau, Sten Libbyvägen 56 inventor only (If this check-box S-187 62 TÄBY is marked, do not fill in below.) Sweden State (that is, country) of residence: State (that is, country) of nationality: SE SE the States indicated in all designated States except the United States of America the United States the Supplemental Box all designated This person is applicant of America only States for the purposes of: Further applicants and/or (further) inventors are indicated on a continuation sheet. AGENT OR COMMON REPRESENTATIVE; OR ADDRESS FOR CORRESPONDENCE Box No. IV The person identified below is hereby/has been appointed to act on behalf common representative agent of the applicant(s) before the competent International Authorities as: Name and address: (Family name followed by given name; for a legal entity, full official designation. The address must include postal code and name of country.) Telephone No. 8 58085475 +46 Facsimile No. Forsberg, Carl-Göran 586 85742 +46 CelsiusTech S-175 88 JÄRFÄLLA Teleprinter No. Sweden Address for correspondence: Mark this check-box where no agent or common representative is/has been appointed and the

space above is used instead to indicate a special address to which correspondence should be sent. Form PCT/RO/101 (first sheet) (July 1998; reprint July 1999)

See Notes to the request form

Sheet No.

Box N	o.V	DESIGNATION OF STATES			in the bound of least one must be marked).
The fo	llowin	g designations are hereby made under Rule 4.9(a) (n	nark the	e appu	cable check-boxes; at least one must be markedy.
Regio					
Ki	AP	ARIPO Patent: GH Ghana, GM Gambia, KE Kenya,	LSLes	sotho. s a Co	MW Malawi. SD Sudan, SL Sierra Leone, SZ Swaziland. ontracting State of the Harare Protocol and of the PCT
Ø	EA	Eurasian Patent: AM Armenia AZ Azerbaijan, Moldova RU Russian Federation, TJ Tajikistan CT	M Tur	kmen	istan, and any other State which is a Contracting State
Ø	EP	European Patent: AT Austria, BE Belgium, CH DK Denmark, ES Spain, FI Finland, FR France, GB MC Monaco, NL Netherlands, PT Portugal, SE Swe	den, an	d any	dom, GR Greece, IE Ireland, IT Italy, LU Luxembourg, other State which is a Contracting State of the European
Ø	OA	OAPI Patent: BF Burkina Faso, BJ Benin, CF Cent GA Gabon, GN Guinea, GW Guinea-Bissau, ML Ma any other State which is a member State of OAPI an	d a Co	ntract	Republic, CG Congo, CI Côte d'Ivoire, CM Cameroon, ritania, NE Niger, SN Senegal, TD Chad, TG Togo, and ing State of the PCT (if other kind of protection or treatment
Nation	al Pate	assired, specify on treatment desired, specify at (if other kind of protection or treatment desired, specify	on dott	ed line	z):
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	CZ	Czech Republic	\boxtimes	PT	Portugal
Ø	DE	Germany	\boxtimes	RO	
Ø	DΚ	Denmark	\boxtimes	RU	Russian Federation
×	EE	Estonia	X	SD	Sudan
×	ES	Snain	Ø	SE	Sweden
×	FI	Finland		SG	Singapore
×	GB		X	SI	Slovenia
		Grenada	×	SK	
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× ×		Croatia	⊠	TR	Turkey
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l 🛭	1 LK	Sri Lanka		· · ·	Line also makes under Pule 4 9(b) all other

Precautionary Designation Statement: In addition to the designations made above, the applicant also makes under Rule 4.9(b) all other designations which would be permitted under the PCT except any designation(s) indicated in the Supplemental Box as being excluded from the scope of this statement. The applicant declares that those additional designations are subject to confirmation and that any designation which is not confirmed before the expiration of 15 months from the priority date is to be regarded as withdrawn by the applicant designation which is not confirmed before the expiration of 15 months from the priority date is to be regarded as withdrawn by the applicant at the expiration of that time limit. (Confirmation of a designation consists of the filing of a notice specifying that designation and the payment of at the expiration of that time limit.)

Box No. VI PRIORITY CI	LAIM		Further prio	rity claims are indicated	in the Supplemental Box.
DOX 1100		Number		Where earlier applicat	
Filing date of earlier application (day/month/year)	of earli	ier application	national application: country	regional application:* regional Office	international application: receiving Office
item (1)					
12.3.1999	9900	885-6	SE		SE
item (2)			<u>.</u>		
item (3)					
The receiving Office is recoff the earlier application (spurposes of the present into	s) (only ij	ine euriter appin	a receiving Office) identif	ied above as item(s):	(1)
purposes of the present int * Where the earlier application is Convention for the Protection of It	an ARIPO	application, it is n	nandatory to indicate in the S hat earlier application was fi	Supplemental Box at least (led (Rule 4.10(b)(ii)). See	one country party to the Paris Supplemental Box.
Box No. VII INTERNATIO	NAL SE	ARCHING AUT	THORITY		
Cl. : Slaterational Searc	hing Auth	ority(ISA) Re		rlier search; reference	to that search (if an earlier ational Searching Authority):
(if two or more International Se. competent to carry out the intern the Authority chosen; the two-lette	ational sea	rch, indicate	rch has been carried out by or te (day/month/year)	Number	Country (orregional Office)
ISA/				<u> </u>	
Box No. VIII CHECK LIST		UAGE OF FILL	al application is accompa	nied by the item(s) mark	ced below:
This international application of the following number of sheet	ts:	This internation 1. fee calcu		incu by the nom(e) come	
request :	3		signed power of attorney		
description (excluding sequence listing part)	8	3. ⊠ copy of	general power of attorney;		ny:
claims :	3		t explaining lack of signat		٠
abstract :	1		document(s) identified in l		
drawings	4	6. Translatio	on of international applica	tion into (language):	or other higherical material
sequence listing part of description		7. separate	indications concerning de de and/or amino acid sequ	ence listing in computer	or other biological material readable form
<u> </u>	19	9. other (sp		oute upand camb	
Total number of sheets: Figure of the drawings which	<u> </u>	L	anguage of filing of the	English	
should accompany the abstrac	t:		ternational application:		
Box No. IX SIGNATURE Next to each signature, indicate the r	OF APP	LICANT OR A	ENI canacity in which the person!	signs (if such capacity is not o	obvious from reading the request).
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TRANSMITTAL FEE	8510
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Applicant's or agent's file reference	FOR FURTHER ACTION See paragraphs 1 and 4 below
3774 PCT	International filing date
International application No.	(day/month/year) 09-03-2000
PCT/SE00/00470	
Applicant CelsiusTech Electronics AB et al	
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	nts is normally 2 months from the date of transmittal of the or more details, see the notes on the accompanying sheet.
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INTERNATIONAL SEARCH REPORT

(PCT Article 18 and Rules 43 and 44)

Applicant's or agent's file reference 3774 PCT	FOR FURTHER ACTION	see Notification of I (Form PCI/ISA/220	ransmittal of International Search Report 1) as well as, where applicable, item 5 below.
International application No.	International filing date	(day/month/year)	(Earliest) Priority Date (day/month/year)
PCT/SE 00/00470	9 March 2000		12 March 1999
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applicant according to Article 18. A	copy is being transmitted	to the internation	ng Authority and is transmitted to the al Bureau.
This international search report cons X It is also accompanied by a	and the second s		nis report.
A It is also accompanied by a			·
1. Certain claims were found u	insearchable (See Box 1).		
2. Unity of invention is lacking	g (See Box 11).		
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4. With regard to the title,	he text is approved as suf	omitted by the app	licant.
	he text has been establish	ed by this Authori	ity to read as follows:
Qua	ntum well based	l two-dimer	nsional detector for IR
rad	iation and came	era system	with such a detector
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1	ne text is approved as sub		ule 38.2(b), by this Authority as it appears
is	ne text has been established Box III. The applicant in actional search report, sub-	nay, within one m	onth from the date of mailing of this inter-
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6. The figure of the drawings to be	published with the abstrates as suggested by the application		None of the figures.
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A. CLASSIFICATION OF SUBJECT MATTER

IPC7: H01L 31/0236, H01L 31/09, G01J 5/20, H04N 5/33 According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC7: H01L, G01J, H04N

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

SE,DK,FI,NO classes as above

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No
A	EP 0617471 A2 (NIPPON TELEGRAPH AND TELEPHONE CO.), 28 Sept 1994 (28.09.94), column 9, claim 15	1-10
	·	
A	US 5485015 A (KWONG-KIT CHOI), 16 January 1996 (16.01.96), figures 7,8	1-10
A	US 5539206 A (THOMAS R. SCHIMERT), 23 July 1996 (23.07.96), abstract	1-10
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X	Further documents are listed in the continuation of Box	C.	X See patent farmily annex.
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INTERNATIONAL SEARCH REPORT

International application No.
PCT/SE 00/00470

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C (Continu	nation). DOCUMENTS CONSIDERED TO BE RELEVANT		
Category*	Citation of document, with indication, where appropriate, of the releva	nt passages	Relevant to claim No
A	IEEE ELECTRON DEVICE LETTERS, Volume 16, No 2, February 1995, K. L. Tsai et al, "Two-Dime Bi-Periodic Grating Coupled One- and Two-Co Quantum Well Infrared Photodetectors", colu line 7, figure 1	ensional olor umn 2,	1-10
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INTERNATIONAL SEARCH REPORT Information on patent family members

International application No.

02/12/99

PCT/SE 00/00470

	tent document in search repor	rt	Publication date		Patent family member(s)	Publication date
EP	0617471	A2	28/09/94	JP US US	7231144 A 5585957 A 5689358 A	29/08/95 17/12/96 18/11/97
US	5485015	A	16/01/96	NON	E	
US	5539206	Α .	23/07/96	CA EP JP NO WO	2220834 A 0824762 A 11504763 T 974814 A 9633515 A	24/10/96 25/02/98 27/04/99 17/10/97 24/10/96

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NOTICE INFORMING THE APPLICANT OF THE COMMUNICATION OF THE INTERNATIONAL APPLICATION TO THE DESIGNATED OFFICES

(PCT Rule 47.1(c), first sentence)

From the INTERNATIONAL BUREAU

FORSBERG, Carl-Göran Bofors Support AB Patents and Trademarks S-691 80 Karlskoga SUÈDE

IMPORTANT NOTICE

Date of mailing (day/month/year)

21 September 2000 (21.09.00)

Applicant's or agent's file reference

3774 PCT

International application No. PCT/SE00/00470

International filing date (day/month/year)

Priority date (day/month/year)
12 March 1999 (12,03.99)

09 March 2000 (09.03.00)

Applicant

CELSIUSTECH ELECTRONICS AB et al

 Notice is hereby given that the International Bureau has communicated, as provided in Article 20, the international application to the following designated Offices on the date indicated above as the date of mailing of this Notice: AU,KP,KR,US

In accordance with Rule 47.1(c), third sentence, those Offices will accept the present Notice as conclusive evidence that the communication of the international application has duly taken place on the date of mailing indicated above and no copy of the international application is required to be furnished by the applicant to the designated Office(s).

2. The following designated Offices have waived the requirement for such a communication at this time:

AE,AL,AM,AP,AT,AZ,BA,BB,BG,BR,BY,CA,CH,CN,CU,CZ,DE,DK,EA,EE,EP,ES,FI,GB,GD,GE,GH,GM,HR,HU,ID,IL,IN,IS,JP,KE,KG,KZ,LC,LK,LR,LS,LT,LU,LV,MD,MG,MK,MN,MW,MX,NO,NZ,OA,PL,PT,RO,RU,SD,SE,SG,SI,SK,SL,TJ,TM,TR,TT,UA,UG,UZ,VN,YU,ZA,ZW
The communication will be made to those Offices only upon their request. Furthermore, those Offices do not require the applicant to furnish a copy of the international application (Rule 49.1(a-bis)).

 Enclosed with this Notice is a copy of the international application as published by the International Bureau on 21 September 2000 (21.09.00) under No. WO 00/55922

REMINDER REGARDING CHAPTER II (Article 31(2)(a) and Rule 54.2)

If the applicant wishes to postpone entry into the national phase until 30 months (or later in some Offices) from the priority date, a demand for international preliminary examination must be filed with the competent International Preliminary Examining Authority before the expiration of 19 months from the priority date.

It is the applicant's sole responsibility to monitor the 19-month time limit.

Note that only an applicant who is a national or resident of a PCT Contracting State which is bound by Chapter II has the right to file a demand for international preliminary examination.

REMINDER REGARDING ENTRY INTO THE NATIONAL PHASE (Article 22 or 39(1))

If the applicant wishes to proceed with the international application in the national phase, he must, within 20 months or 30 months, or later in some Offices, perform the acts referred to therein before each designated or elected Office.

For further important information on the time limits and acts to be performed for entering the national phase, see the Annex to Form PCT/IB/301 (Notification of Receipt of Record Copy) and Volume II of the PCT Applicant's Guide.

The International Bureau of WIPO 34, chemin des Colombettes 1211 Geneva 20, Switzerland Authorized officer

J. Zahra

Telephone No. (41-22) 338.83-38

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INTERNATIONAL APPLICATION PUBLISHED UNDER THE PATENT COOPERATION TREATY (PCT)

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(72) Inventor; and

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(74) Agent: FORSBERG, Carl-Göran; Bofors Support AB, Patents and Trademarks, S-691 80 Karlskoga (SE).

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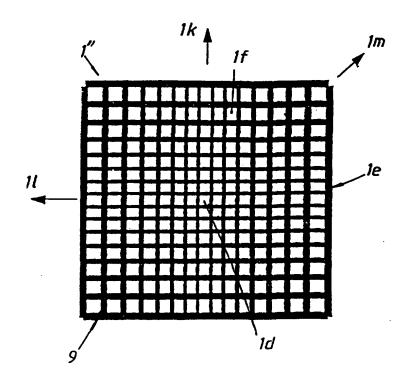
Before the expiration of the time limit for amending the claims and to be republished in the event of the receipt of amendments.

In English translation (filed in Swedish).

(54) Title: QUANTUM WELL BASED TWO-DIMENSIONAL DETECTOR FOR IR RADIATION AND CAMERA SYSTEM WITH SUCH A DETECTOR

(57) Abstract

A quantum well based two-dimensional detector (1) for detecting infrared radiation which receives infrared radiation falling upon its detector surface (1a) at various angles of incidence. The detector comprises a grating arrangement for diffraction of the incident radiation. The arrangement is selected with a grating interval which varies or changes from the central part of the detector out towards the outer parts of the detector. The variation or change in the grating interval is arranged to retain in the detection diffracted rays of the orders 1 and -1 as active components over the whole detector surface by changing the angle values of the diffracted rays depending upon the angles of incidence of the radiation falling on various parts of the detector surface.



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Quantum well based two-dimensional detector for IR radiation and camera system with such a detector

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This invention concerns a quantum well based twodimensional detector for detecting infrared radiation which receives infrared radiation falling upon its detector surface at various angles of incidence within a range of $0-30^{\circ}$ in relation to the normal to the surface. The detector comprises a grating arrangement incident radiation. diffraction of the invention also concerns a camera system for infrared radiation and comprising optics with an aperture and cooling unit and a quantum well based two-dimensional detector which receives via the aperture infrared radiation falling at various angles of incidence within range of 0-30° in relation to the normal to the detector surface. The detector comprises in addition a grating arrangement for diffraction of the incident radiation.

The use of diffraction gratings of various kinds already known for the purpose of increasing the sensitivity of a quantum well based detector infrared radiation, а so-called OWIP detecting Well Infrared Photodetector). (Quantum detector Reference can be made to the Swedish patent 9101034 and the American patents 5 075 749 and 5 506 419. QWIP detectors are completely insensitive to radiation which perpendicular to the surface, but introduction of a grating the direction of the incident radiation can be changed so that this can be absorbed by the detector structure. The grating is normally arranged so that the detector is most sensitive to to falling perpendicular the detector radiation surface.

The use of such detectors in IR camera systems is already known, where the detectors are combined with optics and cooling devices. An important component in

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this respect is the so-called cold aperture which is usually integrated with the detector in a vacuum flask (Dewar vessel). The cold aperture limits the angles of incidence of the radiation which falls on the detector.

A OWIP detector which is equipped with a throughput grating as above is usually sensitive within a relatively narrow range of angles. In particular this arrangement is when а grating with the abovementioned Swedish patent, accordance where the grating constant or grating interval selected so that the angles of diffraction are almost 90°. It only requires a very small change in the angle of incidence for the angle of diffraction to exceed 90° in relation to the normal to the detector surface whereupon the diffracted ray in question is lost as an active component in the detection, which results in a sudden reduction in the through-put efficiency.

In order for radiation to be detected by the detector it is necessary for the angles of incidence to lie within a range of angles where the detector is 20 sensitive. For points which lie straight in front of the detector, that is straight in front of the cold aperture, all these rays will lie within a range of angles around 0°, which means that most of the radiation can be detected. On the other hand for points at the 25 edge of the detector surface the rays fall principally at oblique angles, where previously known detectors have poor sensitivity. This is shown in figures 1 and 2 where A shows the radiation falling on the centre of the detector surface via the cold aperture and B shows 30 radiation falling on the outer edges of detector surface via the cold aperture. There is a need to be able to obtain even sensitivity over the whole detector surface in order to be able to achieve a better picture quality. This invention aims to solve 35 this problem, among others.

In connection with the camera system there is also the requirement to be able to make the optics smaller

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and reduce the cooling requirement in the system. The invention also intends to solve this problem.

according to detector the invention be characterized in that the principally arrangement is selected with a grating interval which varies or changes from the central part of the detector or the detector surface out towards the outer parts or circumference of the detector or detector surface. further characterized in that the variation change in the grating interval is arranged to retain or in the detection towards retaining contribute diffracted rays of the orders of 1 and -1 as active components over the whole detector surface by changing the angle value of the diffracted rays depending upon the angles of incidence of the radiation falling upon the various parts of the detector surface.

In the embodiments of the invention concept it is proposed that the grating interval varies linearly or in steps. Elements included in the grating arrangement vary in the horizontal cross-section of the grating arrangement in configuration size and/or shape and are, for example, square in the central part of the detector surface and change to a rectangular form in the part of the grating arrangement towards the outer parts or the circumference of the detector surface. around embodiments of the invention concept Further described in the following patent claims regarding the construction of the detector.

A camera system according to the invention can principally be characterized in that, as described above, the grating arrangement is selected with a grating interval which varies or changes from the central part of the detector out towards the outer parts of the detector and that the grating interval or the change is selected to diffract rays which pass through the edge of the aperture, that is rays with the largest angle of incidence, by a value up to or exactly equal to 90° in relation to the normal to the detector surface. Other rays which pass through the aperture are

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diffracted by smaller angles than the abovementioned value, but are still close to 90° . The abovementioned values are selected preferably within the range approximately 85° - 90° .

By means of the invention described above a more even and more stable sensitivity is obtained over the whole detector surface which, as described above, gives a better picture quality. In connection with the new camera system this can be further refined in relation to the current technology.

DESCRIPTION OF THE FIGURES:

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In the following a currently proposed embodiment of a detector and a camera system according to the invention will be described with reference to the attached figures, where

- figure 1 shows in principal diagram form and from the side IR radiation falling through an aperture onto the centre of the detector surface in accordance with already known technology,
- figure 2 shows in principal diagram form and from the side radiation falling through an aperture onto the outer edge of the detector related to the sensitivity area of the detector, where the figure shows the case for known technology,
- figure 3 shows in horizontal view from underneath and in principle a first embodiment of a detector with the new grating arrangement, not to scale,
 - figure 4 shows in horizontal view from underneath and in principle a second embodiment of the detector's grating arrangement, not to scale,
 - figure 5 shows in diagrammatic form the linearly increasing grating interval from the centre of the detector surface out towards one outer edge of the detector surface,

figure 6 shows in diagrammatic form the grating interval increasing or changing in steps from the centre of the detector surface out towards one outer edge of the detector,

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5 figure 7 shows in principal diagram form the case when diffracted rays are lost as active components in reproduction in detectors of known types, and

figure 8 shows in principal diagram form the diffraction of the infrared radiation falling on the detector surface at an angle via the aperture in accordance with the invention where the rays falling on the first edge of the detector surface are reproduced.

Figures 1 and 2 refer principally to the problems which are associated with already known detectors and camera systems. Figure 1 shows a radiation area A for incident infrared radiation which falls on the detector 1 at the central parts 1b of its detector surface la. Detector 1 can be of a known type and in this connection reference is made to the Swedish and American patents mentioned in the introduction which concern the construction of a so-called QWIP detector. A so-called cold aperture is indicated by 2. centrally incident radiation is shown by arrows and lines 3 and 4. The detector is principally sensitive within an area which is represented by the angle α . From the figure it can be seen that the area of sensitivity (the cone) covers the whole of the opening of the aperture 2a. The incident radiation 3, 4 falls within the area of sensitivity 5, 6 of the detector over all its extent, which indicates that the detector has a high degree of sensitivity for the incident radiation.

Figure 2 shows that the area of sensitivity of the detector 1' at the outer edge 1c of the detector surface 1a' is only partially accessible to infrared radiation falling at oblique angles, which area is indicated by B. Only a small part can therefore be

detected by the detector, which gives a lower degree of sensitivity for the reception by the detector of the incident oblique radiation. The area of sensitivity of detector only covers a part of the incident radiation 3', 4'. See also the broken lines 5', 6' in figure 2 which show that the area of sensitivity only partially covers the opening 2a' in the aperture. Figure 2 also shows the construction of an IR camera K based on the QWIP detector 1'. The camera comprises an optics part O and a cooling unit KE. The abovementioned components are already known and are incorporated in the camera body KS in a known way. In figure 2 the diameter of the aperture is indicated by D and the distance between the aperture and the upper surface 1a' of the detector is indicated by S.

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accordance with the invention the structure is to be changed according to the angle of incidence of the incident radiation. This preferably that the grating interval is longer at the edge of the detector than in the centre. The grating is preferably two-dimensional in order to be insensitive to polarization of the radiation. Figure 3 shows a grating arrangement viewed from the underside of the detector in question. The detector is indicated in the diagram by 1". The grating element in the embodiment is constructed with quadrilateral configurations. At the central parts 1d of the grating arrangement or of the detector the grating elements are essentially square while at the outer edge le of the detector they are essentially rectangular. A grating element is indicated by 1f in figure 3. The figure is not drawn to scale, but is only an outline diagram.

In accordance with a first embodiment of the invention concept the grating interval varies linearly from the centre 1d of the detector out towards the outer edge 1e of the detector.

The abovementioned variation or change in the grating interval can according to figure 4 be arranged in steps increasing out from the central part 1d' of

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the detector to the outer edge le' of the detector. In the embodiment according to figure 4 the increase in steps in the grating arrangement is arranged using strip-shaped formations 1g and 1h which in principle cross each other at the central part 1d' of the detector. In this way a first density in the grating arrangement is obtained in the area which is covered by both strips 1g and 1h. In parts which are individually covered by the strip-shaped arrangements 1g and 1h a second density is obtained in the grating arrangement. In the corners of the grating arrangement which are symbolized by 1i a third density is obtained for the grating arrangement. The corners li are not crossed by the strip-shaped structures 1g and 1h. The grating interval is smaller at the central parts and increases out towards the outer parts.

The grating arrangement can extend from the central parts of the detector surface out towards the outer edges of the detector surface with grating intervals or steps increasing in principle in all directions which are indicated by 1k, 1l, 1m and 1k', 1l', 1m' respectively in figure 1.

Figure 5 is intended to show the linearly increasing grating interval in the grating arrangement from the central part 1d of the detector 1" out towards its straight outer edge 1e. In a corresponding way figure 6 is intended to show the grating interval increasing in steps from the centre 1d' of the detector 1"' out towards the outer edge 1e' in figure 4.

Figure 7 is intended to show the situation with already known technology. In this case the aperture is indicated by 2a" and the incident ray with the largest angle to the upper surface 1a" of the detector is indicated by 7. Figure 7 is intended to show that diffracted rays of the order 1 have been given an angle ß in relation to the normal 8 to the surface, which angle is greater than 90°. This means that the rays in question are lost as active components in the detection or recording. In figure 7 an angle (gamma) is indicated

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between the incident radiation and the normal 8 to the This maximum angle is preferably selected within the range 0-45°.

Figure 8 shows the improvement according to the invention. The incident radiation 7' which corresponds to the incident radiation 7 in figure 7 is diffracted with diffraction rays of the orders 1 and -1 according to the figure. By the suitable selection of the grating interval the diffraction rays of the order 1 assume a value B' which is 90° or very near 90°, which means that rays in question can be retained as active components, which means that the sensitivity of the detector is increased.

In a preferred embodiment the variation of the grating interval is selected over the detector surface in accordance with the following. The starting point is a given aperture diameter D (see figure 2) at the distance S (see figure 2) from the surface la' of the detector. A grating interval d(x) for a point at the distance x (see figure 2) from the centre 1d of the detector (see figure 3) is selected in such a way that the ray which has the largest angle of incidence is diffracted by precisely 90° in relation to the normal. This ray passes precisely at the edge of the aperture. All other rays which pass through have a smaller angle 25 incidence and are therefore diffracted by angles less than but close to 90° (see above). Expressed mathematically the grating interval is:

$$d(x) = \frac{\lambda}{n - \sin \alpha_{0 \text{max}}(x)}$$

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where λ is the wavelength, n is the diffraction index of the grating substrate and $\alpha_{0\text{max}}$ (x) is the maximum angle of incidence and is given by the formula:

$$\tan \alpha_{0\text{max}}(x) = \frac{x + D/2}{s}$$

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In a second preferred embodiment the grating interval is selected according to a simplified method derived from the method above, by approximation of $\sin\alpha_{0max}$ and $\tan\alpha_{0max}$ by α_{0max} . The grating interval is then given by

$$d(x) = \frac{\lambda}{n} \left(1 + \frac{D}{2nS} + \frac{x}{nS} \right)$$

that is the grating interval varies linearly from the 10 centre out towards the edges.

In an embodiment the following values are selected: λ = 9 µm, D = 7 mm and S = 14 mm. For the substrate or the material GaAs n = 3.28. At the centre of the detector d = 2.95. At the edge, for example 8 mm from the centre, d = 3.43 µm. In an embodiment d is selected at the centre of the detector within a range 2.5 - 3.0 µm and at the outer edge of the detector within a range 3.0 - 3.5 µm, where the higher values are related to each other within both areas, as are the lower values.

Selection of the grating interval d for the value of β ' equal to or close to 90° is obtained by means of

$$\frac{\sin\alpha o}{n} + \sin\beta m = \frac{m\lambda}{nd}$$

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The abovementioned grating arrangement has been given the designation 9 in figure 3 and a graph for the periodicity according to figure 3 has been given the designation 10 in figure 5, while the graph for the periodicity according to figure 4 has been given the designation 11 in figure 6.

This invention is not restricted to the embodiments described above, but can be modified within the framework of the following patent claims and invention concept.

PATENT CLAIMS:

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Quantum well based two-dimensional detector 1 for 4 3, which receives detecting infrared radiation infrared radiation falling upon its detector surface la 5 at various angles of incidence preferably within range of 0-45° in relation to the normal 8 to the surface and comprising a grating arrangement 1f for diffraction of the incident radiation, characterized in that the grating arrangement is selected with a grating 10 interval which varies or changes from the central part 1d of the detector out towards the outer parts le or circumference of the detector, and that the variation or change in the grating interval is arranged to retain contribute towards retaining in the detection 15 diffracted rays of the orders 1 and -1 as active surface whole detector the components across the diffracted changing the angle values of of depending upon the angles incidence α radiation falling on the various parts of the detector 20 surface.

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- 2. Detector according to claim 1, characterized in that the grating interval varies linearly.
- 3. Detector according to claim 1, characterized in that the grating interval varies in steps.
- claim 2 3. 1. or to Detector according characterized in that elements 1f incorporated in the grating arrangement 9 in the horizontal section of the grating arrangement vary the configuration size and/or shape and for example are square at the central part 1d 30 the detector surface and change to rectangular shapes as the grating arrangement 9 extends out towards the outer parts le or circumference of the detector surface.
- 5. Detector according to any of the preceding claims, characterized in that the interval 10, 11 of the grating arrangement is selected so that the detection or sensitivity of the detector is essentially the same over the whole surface 1a of the detector.

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- 6. Detector according to any of the preceding claims, characterized in that the grating interval increases with the distance from the central parts of the detector out towards its outer parts or circumference le.
- 7. Detector according to claim 1 or any of claims 2-6, characterized in that the grating interval varies according to

$$d(x) = \frac{\lambda}{n-\sin\alpha_{0max}(x)}$$

where λ is the wavelength, n is the diffraction index of the grating substrate and $\alpha_{0\text{max}}(x)$ is the maximum angle of incidence and is given by the formula

$$\tan \alpha_{0\text{max}}(x) = \frac{x + D/2}{S}$$

8. Detector according to claim 7, characterized in that the grating interval is selected by approximation of $\sin\alpha_{0max}$ and $\tan\alpha_{0max}$ by α_{0max} , where the grating 20 interval is given by

$$d(x) = \frac{\lambda}{n} \left(1 + \frac{D}{2nS} + \frac{x}{nS} \right).$$

that is the grating interval varies linearly from the centre out towards the edges.

- 9. Detector according to claim 1 or any of claims 2-7, characterized in that the grating interval has values of approximately 2.5-3.0 micrometres at the centre of the detector and approximately 3.0-3.5 micrometres at the outer parts of the detector, where the higher values within both areas are related to each other and the lower values within both areas are related to each other.
- 10. Camera system for infrared radiation and 35 comprising optics O with aperture 2 and cooling unit KE and a quantum well based two-dimensional detector 1

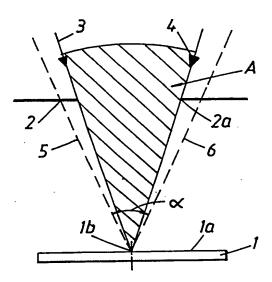
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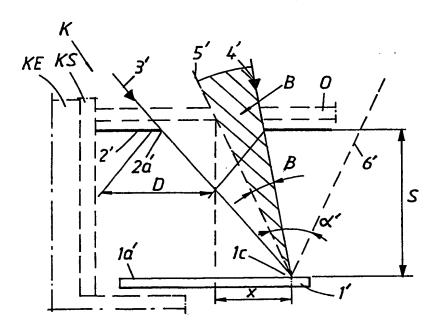
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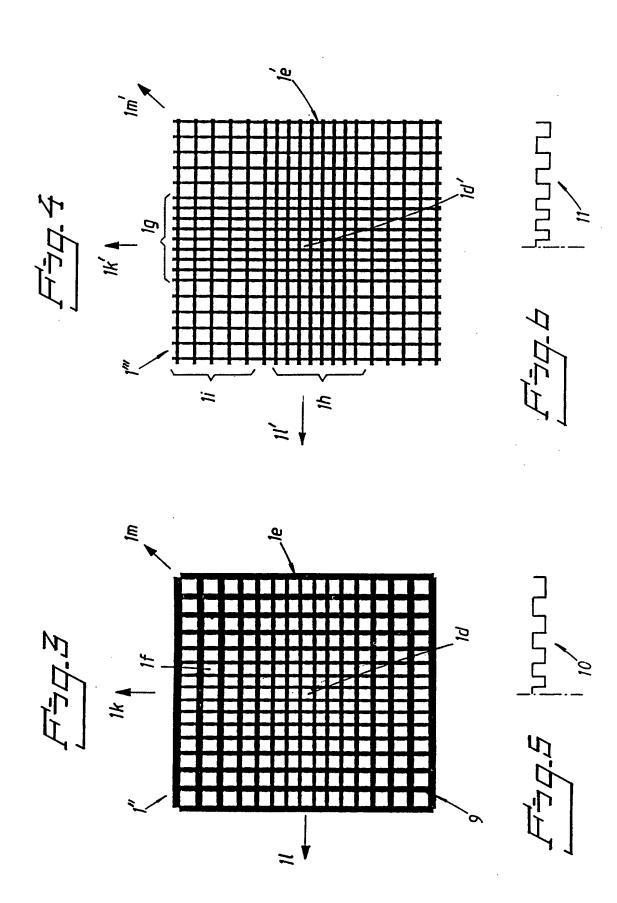
which receives via the aperture infrared radiation 3, 4 falling at various angles of incidence α preferably within a range of 0-45° in relation to the normal 8 to the detector surface, where the detector comprises a grating arrangement for diffraction of the incident radiation characterized in that the grating arrangement is selected with a grating interval which varies or changes from the centre of the detector out towards the outer parts of the detector and in that the grating interval or the change is selected to diffract the rays 7' which pass through the edge of the aperture 2a", that is the rays with the largest angle of incidence, by a value up to or exactly equal to 90° and to diffract rays with smaller angles of incidence by values which are less than the abovementioned value but are still close to 90°, which values are preferably selected within the range 85° - 90°.

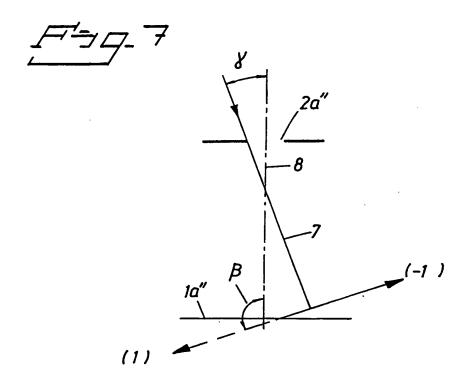


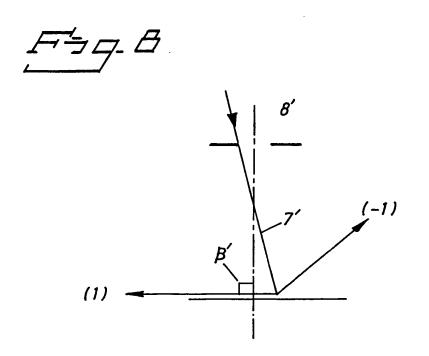


FIRE









INTERNATIONAL SEARCH REPORT



International application No.

PCT/SE 00/00470

A. CLASSIFICATION OF SUBJECT MATTER

IPC7: H01L 31/0236, H01L 31/09, G01J 5/20, H04N 5/33 According to International Patent Classification (IPC) or to both national classification and IPC

B. FIELDS SEARCHED

Minimum documentation searched (classification system followed by classification symbols)

IPC7: H01L, G01J, H04N

Documentation searched other than minimum documentation to the extent that such documents are included in the fields searched

SE,DK,FI,NO classes as above

Electronic data base consulted during the international search (name of data base and, where practicable, search terms used)

Category*	Citation of document, with indication, where appropriate, of the relevant passages	Relevant to claim No.
A	EP 0617471 A2 (NIPPON TELEGRAPH AND TELEPHONE CO.), 28 Sept 1994 (28.09.94), column 9, claim 15	1-10
		
A	US 5485015 A (KWONG-KIT CHOI), 16 January 1996 (16.01.96), figures 7,8	1-10
		
A	US 5539206 A (THOMAS R. SCHIMERT), 23 July 1996 (23.07.96), abstract	1-10
		

X Further documents are listed in the continuation of Box	C. See patent family annex.
* Special categories of cited documents: "A" document defining the general state of the art which is not considered	"[" later document published after the international filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention
to be of particular relevance "E" erlier document but published on or after the international filing date	"X" document of particular relevance: the claimed invention cannot be considered novel or cannot be considered to involve an inventive
"1." document which may throw doubts on priority claim(s) or which is cited to establish the publication date of another citation or other special reason (as specified)	step when the document is taken alone "Y" document of particular relevance: the claimed invention cannot be
"O" document referring to an oral disclosure, use, exhibition or other means "P" document published prior to the international filing date but later than	considered to involve an inventive step when the document is combined with one or more other such documents, such combination being obvious to a person skilled in the art
the priority date claimed Date of the actual completion of the international search	"&" document member of the same patent family Date of mailing of the international search report
6 July 2000	1 4 -07- 2000
Name and mailing address of the ISA/	Authorized officer
Swedish Patent Office Box 5055, S-102 42 STOCKHOLM	STURE ELNÄS/EE
Facsimile No. + 46 8 666 02 86	Telephone No. + 46 8 782 25 00





International application No.

PCT/SE 00/00470

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C (Continu	ation). DOCUMENTS CONSIDERED TO BE RELEVANT		
Category*	Citation of document, with indication, where appropriate, of the releva	int passages	Relevant to claim No
Α	IEEE ELECTRON DEVICE LETTERS, Volume 16, No 2, February 1995, K. L. Tsai et al, "Two-Dimo Bi-Periodic Grating Coupled One- and Two-Co Quantum Well Infrared Photodetectors", colu line 7, figure 1	ensional olor umn 2,	1-10
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Form PCT/ISA/210 (continuation of second sheet) (July 1992)



INTERNATIONAL SEARCH REPORT

Information on patent family members

02/12/99

International application No. PCT/SE 00/00470

Patent document cited in search report		Publication date	Patent family member(s)				Publication date
EP	0617471	A2	28/09/94	JP US US	7231144 A 5585957 A 5689358 A	29/08/95 17/12/96 18/11/97	
US	5485015	A	16/01/96	NON	E		
US	5539206	A	23/07/96	CA EP JP NO WO	2220834 A 0824762 A 11504763 T 974814 A 9633515 A	24/10/96 25/02/98 27/04/99 17/10/97 24/10/96	

2000 -04- 06

PCT •

REQUEST

The undersigned requests that the present international application be processed according to the Patent Cooperation Treaty.

	For receive Office use only
International .	PCT/ SE 00 / 0 0 4 7 0 Application No.
International	2000 -03- 0 9
Name of rece	The Swedish Patent Office PCT International Application iving Office and "PCT International Application"

Applicant's or agent's file reference (if desired) (12 characters maximum)

3774 PCT

105	if desired) (12 characters maximum) 3774 PC1
Box No. I TITLE OF INVENTION	
Quantum well based two-dimensional camera system with such a detector	
Box No. II APPLICANT	
Name and address: (Family name followed by given name; for a let designation. The address must include postal code and name of count address indicated in this Box is the applicant's State (that is, country) of residence is indicated below.)	(rv.) ne courilly of the first lines nerson is also inventor
by residence is indicated octomy	Telephone No.
CelsiusTech Electronics AB S-175 88 JÄRFÄLLA Sweden	Facsimile No.
Sweden	Teleprinter No.
	15.55
State (that is, country) of nationality:	State (that is, country) of residence:
SE	SE States except
This person is applicant for the purposes of: all designated x all designated the United States	
Box No. III FURTHER APPLICANT(S) AND/OR (FURTH	ER) INVENTOR(S)
Name and address: (Family name followed by given name; for a let designation. The address must include postal code and name of count address indicated in this Box is the applicant's State (that is, country) of residence is indicated below.)	gal entity, full official try. The country of the of residence if no State This person is: applicant only
Lindau, Sten Libbyvägen 56	x applicant and inventor
S-187 62 TÄBY Sweden	inventor only (If this check-box is marked, do not fill in below.)
State (that is, country) of nationality:	State (that is, country) of residence:
This person is applicant all designated for the purposes of:	States except the United States of America only the States indicated in the Supplemental Box
Further applicants and/or (further) inventors are indicated on	
Box No. IV AGENT OR COMMON REPRESENTATIVE;	
The person identified below is hereby/has been appointed to act on of the applicant(s) before the competent International Authorities a	behalf x agent common representative is:
Name and address: (Family name followed by given name; for a l designation. The address must include postal coa	
Forsberg, Carl-Göran	Facsimile No.
Bofors Support AB Patents and Trademarks	+46 586 85742
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Sweden	
Address for correspondence: Mark this check-box where no space above is used instead to indicate a special address to where the special address to what is the special address to t	o agent or common representative is/has been appointed and the

Form PCT/RO/101 (first sheet) (July 1998; reprint January 2000)

See Notes to the request form

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Sheet No.

	Box No.V DESIGNATION OF STATES										
The fo	ollowi	ng designations are hereby made under Rule 4.9(a) (mo	ark th	e appl	icable check-boxes: at least one must be marked):						
Regional Patent											
X	AP	ARIPO Patent: GH Ghana, GM Gambia, KE Kenya, I UG Uganda, ZW Zimbabwe, and any other State wh	nch i	s a C	MW Malawi. SD Sudan, SL Sierra Leone, SZ Swaziland. ontracting State of the Harare Protocol and of the PCT						
×	EA	Eurasian Patent: AM Armenia, AZ Azerbaijan, BY Belarus, KG Kyrgyzstan, KZ Kazakhstan, MD Republic of Moldova, RU Russian Federation, TJ Tajikistan, TM Turkmenistan, and any other State which is a Contracting State of the Eurasian Patent Convention and of the PCT									
×	EP	European Patent: AT Austria, BE Belgium, CH and LI Switzerland and Liechtenstein, CY Cyprus, DE Germany, DK Denmark, ES Spain, FI Finland, FR France, GB United Kingdom, GR Greece, IE Ireland, IT Italy, LU Luxembourg, MC Monaco, NL Netherlands, PT Portugal, SE Sweden, and any other State which is a Contracting State of the European Patent Convention and of the PCT									
×	OA	OAPI Patent: BF Burkina Faso, BJ Benin, CF Central African Republic, CG Congo, CI Côte d'Ivoire, CM Cameroon, GA Gabon, GN Guinea, GW Guinea-Bissau, ML Mali, MR Mauritania, NE Niger, SN Senegal, TD Chad, TG Togo, and any other State which is a member State of OAPI and a Contracting State of the PCT (if other kind of protection or treatment desired, specify on dotted line)									
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Precautionary Designation Statement: In addition to the designations made above, the applicant also makes under Rule 4.9(b) all other designations which would be permitted under the PCT except any designation(s) indicated in the Supplemental Box as being excluded from the scope of this statement. The applicant declares that those additional designations are subject to confirmation and that any designation which is not confirmed before the expiration of 15 months from the priority date is to be regarded as withdrawn by the applicant at the expiration of that time limit. (Confirmation of a designation consists of the filing of a notice specifying that designation and the payment of the designation and confirmation fees. Confirmation must reach the receiving Office within the 15-month time limit.)

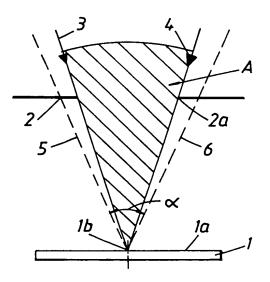
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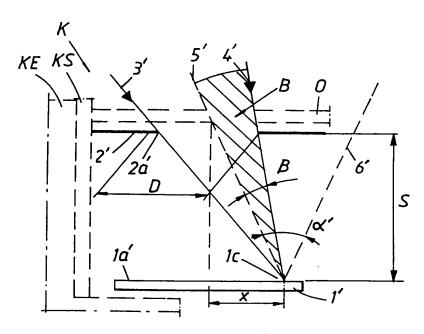
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Box No. VI PRIORITY C	LAIM		Further prio	rity claims are indicated	in the Supplemental Box.]	
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of earlier application (day/month/year)	of earlier applicati	nati	onal application: country	regional application:* regional Office	international application: receiving Office]	
item (1)						İ	
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item (2)							
item (3)							
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Choice of International Searci (if two or more International Secompetent to carry out the interna- the Authority chosen; the two-lette.	arching Authorities are ational search, indicate	search has b Date (day/n	heen carried out by or i nonth/year)	requested from the Internal Number	to that search (if an earlier tional Searching Authority): Country (or regional Office)		
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Box No. VIII CHECK LIST						-	
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request :	J V "		power of attorney				
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3. Corrected date of actual receipt due to later but timely received papers or drawings completing the purported international application:							
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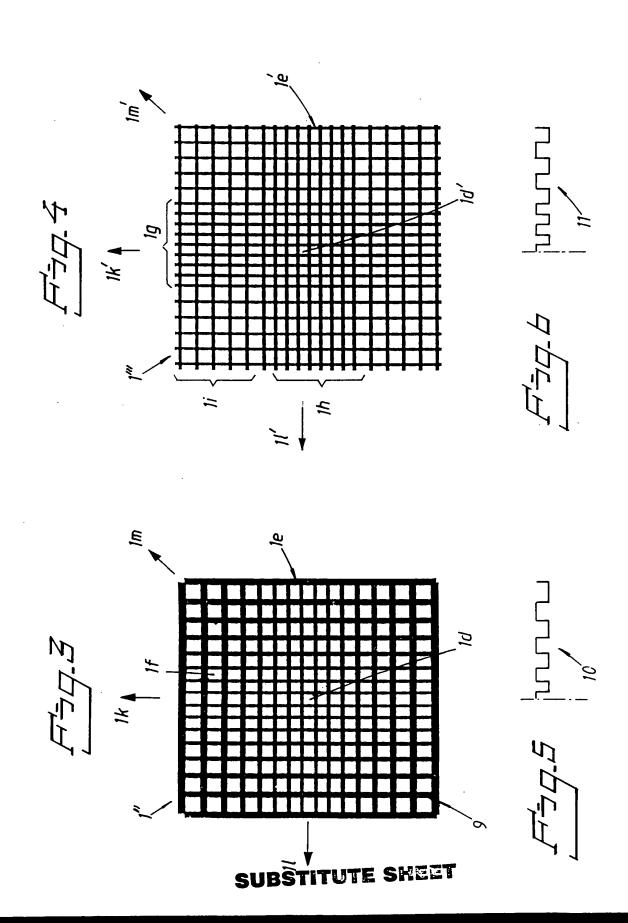




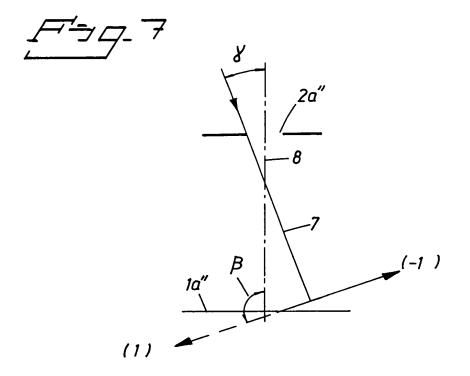
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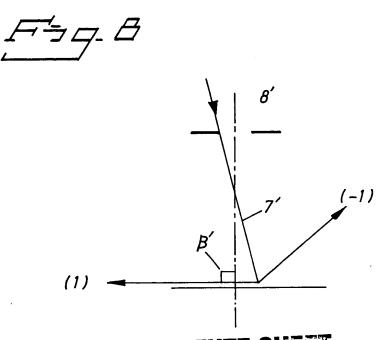


SUBSTITUTE SHEET



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Substitute sheet

Kvantbrunnsbaserad och tvådimensionell detektor för IR-strålning och kamerasystem med sådan detektor.

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Föreliggande uppfinning avser en kvantbrunnsbaserad och infraröd strålning avkännande, tvådimensionell detektor som på sin detektoryta mottar infallande infraröd strålning med olika infallsvinklar inom ett område om 0-30° i förhållande till ytans normal. Detektorn innefattar ett gitterarrangemang för diffraktion av den infallande strålningen. Uppfinningen avser även ett kamerasystem för infraröd strålning och innefattande optik med bländare och kylenhet samt en kvantbrunnsbaserad, tvådimensionell detektor som mottar den via bländaren under olika infallsvinklar inom ett område av 0-30° i förhållande till detektorytans normal infallande infraröda strålningen. Detektorn innefattar därvid ett gitterarrangemang för diffraktion av den infallande strålningen.

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Det är känt att utnyttja diffraktionsgitter av olika slag för att höja känsligheten hos en kvantbrunnsbaserade infraröd strålning avkännande detektor, en s.k. QWIP-detektor (Quantum Well Infrared Photodetector). Det kan därvid hänvisas till det svenska patentet 9101034 och de amerikanska patenten 5 075 749 och 5 506 419. QWIP-detektorn i sig är helt okänslig för strålning som infaller vinkelrätt mot ytan, men genom införandet av ett gitter ändras riktningen på den infallande strålningen så att denna kan absorberas i detektorstrukturen. Gittret anpassas normalt så att detektorn blir mest känslig för vinkelrätt mot detektorytan infallande strålning.

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Det är i och för sig känt att utnyttja dylika detektorer i IR-kamerasystem, i vilka detektorn kombineras med optik och kylanordning. En viktig komponent härvidlag är den s.k. kalla bländaren, som vanligen är integrerad med detektorn i en vakuumbehållare (dewar). Den kalla bländaren begränsar infallsvinklarna hos strålningen som träffar detektorn.

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En QWIP-detektor som är försedd med inkopplingsgitter enligt ovan blir normalt känslig inom ett förhållandevis smalt vinkelområde. I synnerhet gäller detta när man utnyttjar gitterarrangemang enligt nämnda svenska patent, där gitterkonstanten eller gitterperioden

är vald så att diffraktionsvinklarna är nära 90°. Det räcker därvid med en mycket liten ändring av infallsvinkeln för att diffraktionsvinkeln skall bli över 90° i förhållande till detektorytans normal, varvid den aktuella diffrakterade strålen försvinner som aktiv komponent i avkänningen, vilket medför att en plötslig minskning av inkopplingsverkningsgraden uppkommer.

För att strålningen skall kunna registreras av detektorn krävs att infallsvinklarna hos strålningen ligger inom ett vinkelområde där detektorn är känslig. För punkter som ligger mitt på detektorn, dvs mitt för den kalla bländaren, kommer alla dessa strålar att ligga inom ett vinkelområde kring 0°, vilket medför att den mesta av denna strålningen kan registreras. Däremot gäller för punkter i kanten av detektorytan att strålarna infaller huvudsakligen i sneda vinkar, där förut kända detektorer har dålig känslighet. Detta har visats i figurerna 1 och 2 där A visar strålningen via den kalla bländaren mot detektorytans mitt och B visar strålningen via den kalla bländaren mot detektorytans ytterkant. Det föreligger ett behov av att kunna erhålla jämn känslighet över hela detektorytan för att kunna uppnå bättre bildkvalitet. Uppfinningen avser att lösa bl.a. detta problem.

I anslutning till kamerasystem föreligger även önskemål om att kunna göra optiken mindre och minska kylbehovet i systemet. Uppfinningen avser att lösa även detta problem.

Det som huvudsakligen kan anses vara kännetecknande för en detektor enligt uppfinningen är att gitterarrangemanget är valt med en gitterperiod som varierar eller förändrar sig från detektorns eller detektorytans mittre del och ut mot detektorns respektive detektorytans yttre delar eller omkretsdelar. Ett ytterligare kännetecken är att gitterperiodens variation eller förändring är anordnad för eller bidrar till att i avkänningen bibehålla diffrakterade strålar av ordningarna 1 och –1 som aktiva komponenter över hela detektorytan genom att anpassa de diffrakterade strålarnas vinkelvärden i beroende av infallsvinklarna på den infallande strålningen vid detektorytans olika delar.

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I utföringsformer av uppfinningstanken föreslås att gitterperioden skall variera linjärt eller stegvis. I gitterarrangemanget ingående element varierar i gitterarrangemangets horisontalsnitt sina konfigurationsstorlekar och/eller konfigurationer och är t.ex. kvadra-

tiska vid detektorytans mittre delar och övergår i rektangulära former vid gitterarrangemangets sträckning ut mot detektorytans yttre delar eller omkretsdelar. Ytterligare utföringsformer av uppfinningstanken framgår av efterföljande underkrav till detektoruppbyggnaden.

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Det som huvudsakligen kan anses vara kännetecknande för ett kamerasystem enligt uppfinningen är att gitterarrangemanget i likhet med ovan är valt med en gitterperiod som varierar eller förändrar sig från detektorns mittre del och ut mot detektorns yttre delar och att gitterperioden eller förändringen är vald att diffraktera strålen som passerar vid bländarens kant, dvs strålen med den största infallsvinkeln, med ett värde intill eller exakt lika med 90° i förhållande till detektorytans normal. Övriga strålar som passerar bländaren kommer då att deffrakteras med mindre vinklar än det förstnämnda värdet, men ändå är nära 90°. Nämnda värden väljes företrädesvis inom området ca 85° - 90°.

Genom det i ovan föreslagna erhålles en utjämnad och mer stabil känslighet utefter hela detektorytan som enligt ovan ger bättre bildkvalitet. I anslutning till det nya kamerasystemet kan detta förfinas ytterligare i förhållande till den kända tekniken.

FIGURFÖRTECKNING

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En för närvarande föreslagen utföringsform av en detektor och ett kamerasystem enligt uppfinningen skall beskrivas i nedanstående under samtidig hänvisning till bifogade ritningar där

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- figur 1 i principschemaform och från sidan visar genom en bländare mot en detektorytas mitt infallande IR-strålning enligt i och för sig känd teknik,
- figur 2 i principschemaform och från sidan visar den via bländaren mot detektorns ytterkant infallande strålningen relaterade till detektorns känslighetsområde, varvid figuren visar fallet för den kända tekniken,

- figur 3 i horisontalvy underifrån och principiellt visar ett detektorn tillhörande nytt gitterarrangemang i ett första utförande, varvid figuren inte är visad skalenlig,
- figur 4 i horisontalvy underifrån och principiellt visar ett andra nytt utförande av detektorns gitterarrangemang, varvid figuren ej är visad skalenlig,

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- figur 5 i diagramform visar linjärt ökande gitterperiod från detektorytans mitt ut mot detektorytans ena ytterkant,
- figur 6 i diagramform visar gitterperiodens stegvisa ökning eller förändring från detektorytans mitt och ut mot detektorns ena ytterkant,
- figur 7 i principschemaform visar fallet där diffrakterad stråle går förlorad som aktiv komponent i återgivningen i anslutning till detektorer av känt slag, och
- figur 8 i principschemaform visar diffrakteringen av den under vinkel via bländaren mot detektorytan infallande infraröda strålningen i enlighet med uppfinningen, varvid strålen mot detektorytans första kant återgivits.

Figurerna 1 och 2 är i första hand hänförbara till problematiken som är knuten till förut kända detektorer och kamerasystem. I figuren 1 anges ett strålningsområde A för den infallande infraröda strålningen som träffar detektorn 1, vid dess detektorytas 1a mittre delar 1b. Detektorn 1 kan vara av i och för sig känt slag och det hänvisas härvid till de inledningsvis omnämnda svenska och amerikanska patenten som anger uppbyggnaden på en s.k. QWIP-detektor. En s.k. kall bländare är angiven med 2. Den centralt infallande strålningen är visad med pilar och linjer 3 och 4. Detektorn är huvudsakligen känslig inom ett område som är representerat med en vinkel α. Av figuren framgår att känslighetsområdet (konen) täcker hela bländarens öppning 2a. Den infallande strålningen 3, 4 faller innanför detektorns känslighetsområde 5, 6 i hela sin utsträckning, vilket indikerar en stor känslighetsgrad hos detektorn för den infallande strålningen.

I figuren 2 visas att detektorns 1' känslighetsområde vid detektorytans 1a' ytterkant 1c endast delvis är tillgängligt för den under sneda vinklar infallande infraröda strålningen, vars område angivits med β. Endast en mindre del kan således registreras av detektorn, vilket ger lägre känslighetsgrad vid detektorns mottagning av den infallande sneda strålningen. Detektorns känslighetsområde täcker endast en del av den infallande strålningen 3', 4'. Jämför även de streckade linjerna 5', 6' i figuren 2 som visar att detektorns känslighetsområde endast delvis täcker öppningen 2a' på bländaren. I figuren 2 visas dessutom principiellt uppbyggnaden av en IR-kamera K baserad på QWIP-detektorn 1'. I kameran ingår en optik O och en kylenhet KE. Nämnda komponenter är i och för sig kända och på i och för sig känt sätt inbyggda i en kamerastomme KS. I figuren 2 är bländarens diameter angiven med D och avståndet mellan bländare och detektorns ovanyta 1a' med S.

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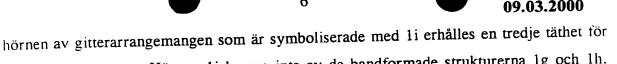
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I enlighet med uppfinningen skall gitterstrukturen anpassas efter infallsvinkeln hos den infallande strålningen. Detta innebär företrädesvis att gitterperioden blir längre i kanten av detektorn än i mitten. Gittret är företrädesvis tvådimensionellt för att vara okänsligt för strålningens polarisation. I figuren 3 är ett gitterarrangemang visat från ifrågavarande detektors undersida. Detektorn är i princip angiven med 1''. Gitterelementen är i utföringsexemplet utformade med fyrkantsformade konfigurationer. Vid gitterarrangemanget eller detektorns mittre delar 1d är gitterelementen väsentligen kvadratiska, medan de vid detektorns ytterkant 1e är väsentligen rektangelformade. Ett gitterelement är i figuren 3 angivet med 1f. Figuren är ej visad skalenlig, utan utgör endast en principskiss.

I enlighet med en första utföringsform av uppfinningstanken varierar gitterperioden linjärt från detektorns mitt 1d ut mot detektorns ytterkant 1e.

Nämnda variation eller förändring av gitterperioden kan i enlighet med figuren 4 anordnas stegformigt och ökande ut från detektorns mittre del 1d' till detektorns ytterkant 1e'. I utföringsexemplet enligt figuren 4 är den stegvisa ökningen i gitterarrangemanget anordnat med hjälp av bandliknande formationer 1g och 1h som i princip korsar varandra vid detektorns mittre delar 1d'. På så sätt erhålles i området som täckes av både bandet 1g och 1h en första täthet i gitterarrangemanget. I delar som var för sig täckes av de bandformade arrangemangen 1g och 1h erhålles en andra täthet i gitterarrangemanget. I



gitterarrangemanget. Hörnen 1i korsas inte av de bandformade strukturerna 1g och 1h. Gitterperioden är mindre vid de mittre delarna och ökar utåt mot de yttre delarna.

Gitterarrangemangen kan sprida sig från detektorytans mittre delar ut mot detektorytans 5 yttre kanter med ökande gitterperiod eller steg i princip alla riktningar som i figur 1 är indikerade med 1k, 1l, 1m respektive 1k', 1l', 1m'.

Figuren 5 är avsedd att visa den linjärt ökande gitterperioden i gitterarrangemanget räknat från detektorns 1" mittre del 1d vinkel ut mot dess raka ytterkant 1e. På motsvarande sätt avser figuren 6 att visa den stegvist ökande gitterperioden från detektorns 1" mitt 1d' vinkelrätt ut mot ytterkanten 1e' i figuren 4.

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Figuren 7 avser att visa fallet vid den tidigare kända tekniken. I detta fall är bländaren principiellt angiven med 2a" och den infallande strålen med den största vinkeln mot detektorns ovanyta 1a" med 7. Figuren 7 avser att visa att diffrakterad stråle av ordningen (1) har erhållit en vinkel β i förhållande till ytans normal 8 som är större än 90°. Detta innebär att ifrågavarande stråle går förlorad som aktiv komponent i avkänningen eller registreringen. I figuren 7 är en vinkel Kangiven mellan den infallande strålningen och ytans normal 8. Sistnämnda maxvinkel väljes företrädesvis inom området 0-45°.

I figuren 8 visas förbättringen enligt uppfinningen. Den infallande strålningen 7' som motsvarar den infallande strålningen 7 enligt figuren 7 diffrakteras med diffraktionsstrålarna av ordningarna 1 och -1 enligt figuren. Genom lämpligt val av gitterperiod kommer diffraktionsstrålen av ordningen 1 att anta ett värde β' som är 90° eller mycket nära 90°, vilket medför att strålen ifråga kan bibehållas som aktiv komponent, vilket ger upphov till att känsligheten hos detektorn ökar.

I en föredragen utföringsform väljs gitterperiodens variation utefter detektorytan i enlighet med följande. Utgångspunkten är därvid en given bländardiameter D (se figuren 2) på avståndet S (se figuren 2) från detektorns yta 1a'. En gitterperiod d(x) för en punkt på avståndet x (se figuren 2) från detektorns mitt 1d (se figuren 3) väljes på så sätt att den stråle som har största infallsvinkeln diffrakteras i precis 90° i förhållande till normalen.

Denna stråle passerar precis kanten av bländaren. Alla andra strålar som släppes igenom har mindre infallsvinkel och diffrakteras därför i vinklar mindre än, men nära 90° (se ovan). Matematiskt uttryckt blir gitterperioden:

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$$d(x) = \frac{\lambda}{n-\sin\alpha_{0max}(x)}$$

där λ är våglängden, n är gittersubstratets brytningsindex och α_{0max} (x) är maximala infallsvinkeln och ges av formeln:

 $\tan\alpha_{0\text{max}}(x) = \frac{x + D/2}{s}$

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I en annan föredragen utföringsform väljs gitterperioden enligt en förenklad metod, härledd ur ovan beskriven metod, genom att approximera $\sin\alpha_{0max}$ och $\tan\alpha_{0max}$ med α_{0max} .

Då ges gitterperioden av

$$d(x) = \frac{\lambda}{n} \left(1 + \frac{D}{2nS} + \frac{x}{nS} \right)$$

det vill säga, gitterperioden varierar linjärt från mitten ut till kanten.

I ett utföringsexempel väljes därvid värdena λ = 9 μm, D = 7 mm och S = 14 mm. För substratet eller materialet GaAs är n = 3,28. Vid detektorns mitt erhålles d = 2,95. Vid kanten, t.ex. 8 mm från mitten blir d = 3,43 μm. I ett utföringsexempel väljes d vid detektorns mitt inom ett område 2,5 - 3,0 μm och vid detektorns ytterkant inom ett område 3,0 - 3,5 μm, varvid de högre värdena är relaterade till varandra inom de båda områdena, liksom de lägre värdena.

Val av gitterperioden d för värden för β' lika med eller nära 90° erhålles medelst

$$\frac{\sin \alpha o}{n} + \sin \beta m = \frac{m\lambda}{nd}$$

Det i ovan omnämnda gitterarrangemanget har erhållit beteckningen 9 i figuren 3 och en kurva för periodiciteten enligt figuren 3 har i figuren 5 erhållit beteckningen 10, medan periodiciteten enligt figuren 4 har erhållit beteckningen 11 i figuren 6.

Uppfinningen är inte begränsad till den i ovan såsom exempel visade utföringsformen 5 utan kan underkastas modifikationer inom ramen för efterföljande patentkrav och uppfinningstanken.

PATENTKRAV

1. Kvantbrunnsbaserad och infraröd strålning (3, 4) avkännande, tvådimensionell detektor (1) som på sin detektoryta (1a) mottar infallande infraröd strålning med olika infallsvinklar, företrädesvis inom ett område 0-45°, i förhållande till ytans normal (8) samt innefattande ett gitterarrangemang (1f) för diffraktion av den infallande strålningen, k ä n- n e t e c k n a d därav, att gitterarrangemanget är valt med en gitterperiod som varierar eller förändrar sig från detektorns mittre del (1d) och ut mot detektorns yttre delar (1e) eller omkretsdelar, och att gitterperiodens variation eller förändring är anordnad eller bidrar till att i avkänningen bibehålla diffrakterade strålar av ordningarna 1 och -1 som aktiva komponenter över hela detektorytan genom att anpassa de diffrakterade strålarnas vinkelvärden i beroende av infallsvinklarna (α) på den infallande strålningen vid detektorytans olika delar.

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- 2. Detektor enligt patentkravet 1, k ä n n e t e c k n a d därav, att gitterperioden varierar linjärt.
- Detektor enligt patentkravet 1, k ä n n e t e c k n a d därav, att gitterperioden varierar stegvis.
 - Detektor enligt patentkravet 1, 2 eller 3, k ä n n e t e c k n a d därav att i gitterarrangemanget (9) ingående element (1f) i gitterarrangemangets horisontalsnitt varierar sina konfigurationsstorlekar och/eller konfigurationer och t.ex. är kvadratiska vid detektorytans mittre del (1d) och övergår i rektangulära former vid gitterarrangemangets (9) sträckning ut mot detektorytans yttre delar (1e) eller omkretsdelar.
 - Detektor enligt något av föregående patentkrav, k ä n n e t e c k n a d därav, att gitterarrangemangets period (10, 11) är vald så att detektorns avkänning eller känslighet blir väsentligen densamma över detektorns hela yta (1a).

6. Detektor enligt något av föregående patentkrav, k ä n n e t e c k n a d därav, att gitterperioden ökar med avståndet från detektorns mittre delar ut mot dess yttre delar eller omkretsdelar (1e).

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7. Detektor enligt patentkravet 1 eller något av patentkraven 2-6, k ä n n e t e c kn a d därav, att gitterperioden varierar enligt

$$d(x) = \frac{\lambda}{n - \sin \alpha_{0 \max}(x)}$$

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där λ är våglängden, n är gittersubstratets brytningsindex och $\alpha_{0max}(x)$ är maximala infallsvinkeln och ges av formeln

$$\tan \alpha_{0\text{max}}(x) = \frac{x + D/2}{S}$$

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8. Detektor enligt patentkravet 7, k ä n n e t e c k n a d därav, att gitterperioden är vald med hjälp av approximation av α_{0max} och tan α_{0max} med α_{0max} , varvid gitterperioden framgår av

$$d(x) = \frac{\lambda}{n} \left(1 + \frac{D}{2nS} + \frac{x}{nS} \right)$$

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dvs gitterperioden varierar linjärt från mitten ut till kanten.

- 9. Detektor enligt patentkravet 1 eller något av patentkraven 2-7, k ä n n e t e c kn a d därav, att gitterperioden uppvisar värden av ca 2,5-3,0 mikrometer vid detektorns
 mitt och ca 3,0-3,5 mikrometer vid detektorns yttre delar, varvid de högre värdena inom de
 båda områdena är hänförbara till varandra och de lägre värdena inom de båda områdena är
 hänförbara till varandra.
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- 10. Kamerasystem för infraröd strålning och innefattande optik (O) med bländare (2) och kylenhet (KE) samt en kvantbrunnsbaserad, tvådimensionell detektor (1) som mottar den via bländaren under olika infallsvinklar (α), företrädesvis inom ett område av 0-45°, i förhållande till detektorytans normal (8) infallande infraröda strålningen (3, 4), varvid detektorn innefattar ett gitterarrangemang för diffraktering av den infallande strålningen, k ä n n e t e c k n a d därav, att gitterarrangemanget är valt med en gitterperiod

som varierar eller förändrar sig från detektorns mittre del och ut mot detektorns yttre delar, och att gitterperioden eller förändringen är vald att diffraktera strålen (7') som passerar vid bländarens (2a'') kant, dvs strålen med den största infallsvinkeln, med ett värde intill eller exakt lika med 90° och att diffraktera strålar med mindre infallsvinklar med värden som understiger det förstnämnda värdet, men ändå är nära 90°, vilka värden företrädesvis är valda inom området 85° - 90°.



En kvantbrunnsbaserad och infraröd strålning avkännande tvådimensionell detektor (1) mottar på sin detektoryta (1a) infallande infraröd strålning med olika infallsvinklar. Detektorn innefattar ett gitterarrangemang för diffraktering av den infallande strålningen. Arrangemanget är valt med en gitterperiod som varierar eller förändrar sig från detektorns mittre del och ut mot detektorns yttre delar. Gitterperiodens variation eller förändring är anordnad att i avkänningen bibehålla diffrakterade strålar av ordningarna 1 och – 1 som aktiva komponenter över hela detektorytan genom att anpassa de diffrakterade strålarnas vinkelvärden i beroende av infallsvinklarna på den infallande strålningen vid detektorytans olika delar.

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